# 2SD2457

## Silicon NPN epitaxial planar type

### For low-frequency output amplification

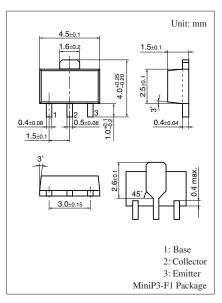
### ■ Features

- High collector-emitter voltage (Base open) V<sub>CEO</sub>
- Low collector power dissipation P<sub>C</sub>
- Mini Power type package, allowing downsizing of the equipment and automatic insertion through the tape packing and the magazine packing.

## ■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage (Emitter open)	V <sub>CBO</sub>	50	V	
Collector-emitter voltage (Base open)	V <sub>CEO</sub>	40	V	
Emitter-base voltage (Collector open)	$V_{EBO}$	5	V	
Collector current	$I_{C}$	1.5	A	
Peak collector current	$I_{CP}$	3	A	
Collector power dissipation *	P <sub>C</sub>	1	W	
Junction temperature	T <sub>j</sub>	150	°C	
Storage temperature	T <sub>stg</sub>	-55 to +150	°C	

Note) \*: Printed circuit board: Copper foil area of 1 cm² or more, and the board thickness of 1.7 mm for the collector portion



Marking Symbol: 1Y

## ■ Electrical Characteristics $T_a = 25$ °C $\pm 3$ °C

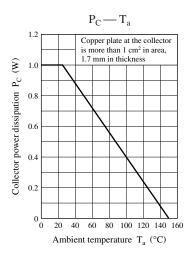
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)	V <sub>CBO</sub>	$I_C = 1 \text{ mA}, I_E = 0$	50			V
Collector-emitter voltage (Base open)	V <sub>CEO</sub>	$I_C = 2 \text{ mA}, I_B = 0$	40			V
Collector-base cutoff current (Emitter open)	$I_{CBO}$	$V_{CB} = 20 \text{ V}, I_{E} = 0$			1	μΑ
Collector-emitter cutoff current (Base open)	I <sub>CEO</sub>	$V_{CE} = 10 \text{ V}, I_{B} = 0$			100	μΑ
Emitter-base cutoff current (Collector open)	$I_{EBO}$	$V_{EB} = 5 \text{ V}, I_{E} = 0$			10	μΑ
Forward current transfer ratio *1, 2	h <sub>FE</sub>	$V_{CE} = 5 \text{ V}, I_{C} = 1 \text{ A}$	80	120	220	_
Collector-emitter saturation voltage *1	V <sub>CE(sat)</sub>	$I_C = 1.5 \text{ A}, I_B = 0.15 \text{ A}$			1.0	V
Base-emitter saturation voltage *1	V <sub>BE(sat)</sub>	$I_C = 2 \text{ A}, I_B = 0.2 \text{ A}$			1.5	V
Transition frequency *1	$f_T$	$V_{CB} = 5 \text{ V}, I_{E} = -0.5 \text{ A}, f = 200 \text{ MHz}$		150		MHz
Collector output capacitance	C <sub>ob</sub>	$V_{CB} = 20 \text{ V}, I_{E} = 0, f = 1 \text{ MHz}$		45		pF
(Common base, input open circuited)						

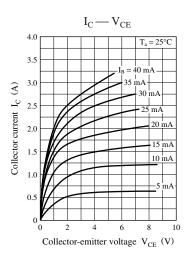
 $Note) \ 1. \ Measuring \ methods \ are \ based \ on \ JAPANESE \ INDUSTRIAL \ STANDARD \ JIS \ C \ 7030 \ measuring \ methods \ for \ transistors.$ 

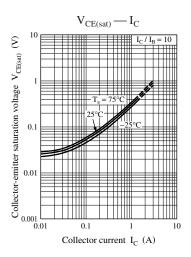
#### 2. \*1: Pulse measurement

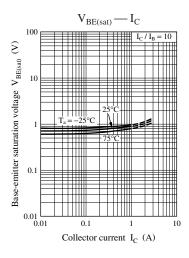
#### \*2: Rank classification

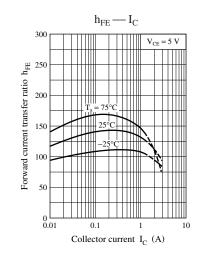
Rank	Q	R
$h_{FE}$	80 to 160	120 to 220

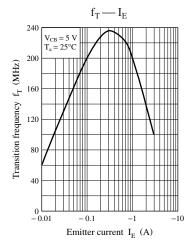


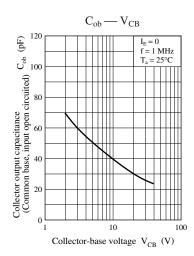












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